Notice of References Cited Application/Control No. 10/824,360 Examiner Diego Herrera Applicant(s)/Patent Under Reexamination PARK, HEE-LA Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0185883 A1	09-2004	Rukman, Jason	455/466
*	В	US-2002/0132608 A1	09-2002	Shinohara, Masahito	455/412
*	С	US-6,892,066 B2	05-2005	Detweiler et al.	455/414.4
*	D	US-2004/0121818 A1	06-2004	Paakkonen, Tarja	455/567
*	Е	US-6,885,872 B2	04-2005	McCann et al.	455/466
*	F	US-6,895,251 B2	05-2005	Soh et al.	455/466
*	G	US-2001/0041578 A1	11-2001	Na, Chung-Seob	455/466
*	Н	US-2003/0040300 A1	02-2003	Bodic et al.	455/412
*	ı	US-2004/0097248 A1	05-2004	Schmidt et al.	455/466
*	J	US-2002/0006797 A1	01-2002	Virtanen et al.	455/445
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	v						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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